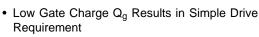


SPU01N60S5-VB Datasheet N-Channel 650V (D-S) Power MOSFET

| PRODUCT SUMMARY | | | | | | |
|---------------------------------|--------------------------|--|--|--|--|--|
| V _{DS} (V) | 650 | | | | | |
| $R_{DS(on)}\left(\Omega\right)$ | V _{GS} = 10 V 4 | | | | | |
| Q _g (Max.) (nC) | 11 | | | | | |
| Q _{gs} (nC) | 2.3 | | | | | |
| Q _{gd} (nC) | 5.2 | | | | | |
| Configuration | Single | | | | | |

FEATURES

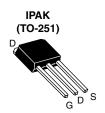


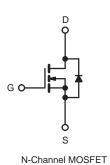


• Improved Gate, Avalanche and Dynamic dV/dt Ruggedness



- Fully Characterized Capacitance and Avalanche Voltage and Current
- Compliant to RoHS directive 2002/95/EC





| ABSOLUTE MAXIMUM RATINGS T | _C = 25 °C, u | nless otherw | ise noted | | | |
|---|--|-------------------------|-----------------------------------|---------------|----------|--|
| PARAMETER | | | SYMBOL | LIMIT | UNIT | |
| Drain-Source Voltage | | | V_{DS} | 650 | V | |
| Gate-Source Voltage | | | V_{GS} | ± 30 | 7 v | |
| Continuous Drain Currente | V _{GS} at 10 V | T _C = 25 °C | 1 | 2.0 | | |
| Continuous Drain Current | V _{GS} at 10 V | T _C = 100 °C | I _D | 1.28 | Α | |
| Pulsed Drain Current ^a | | | I _{DM} | 8 | | |
| Linear Derating Factor | | | | 0.48 | W/°C | |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 165 | mJ | |
| Repetitive Avalanche Current ^a | | | I _{AR} | 2 | Α | |
| Repetitive Avalanche Energy ^a | | | E _{AR} | 6 | mJ | |
| Maximum Power Dissipation T _C = 25 °C | | | P_{D} | 45 | W | |
| Peak Diode Recovery dV/dt ^c | | | dV/dt | 2.8 | V/ns | |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | - 55 to + 150 | °C | |
| Soldering Recommendations (Peak Temperature) ^d | commendations (Peak Temperature) ^d for 10 s | | | 300 | | |
| Mounting Torque | 6 22 or N | C 20 an M2 annous | | 10 | lbf ⋅ in | |
| Mounting Forque | 6-32 or M3 screw | | | 1.1 | N⋅m | |

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T_J = 25 °C, L = 24 mH, R_G = 25 Ω , I_{AS} = 3.2 A (see fig. 12).
- c. $I_{SD} \le 3.2$ A, $dI/dt \le 90$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.
- e. Drain current limited by maximum junction temperature.



| THERMAL RESISTANCE RATINGS | | | | | | |
|----------------------------------|-------------------|------|------|------|--|--|
| PARAMETER | SYMBOL | TYP. | MAX. | UNIT | | |
| Maximum Junction-to-Ambient | R _{thJA} | - | 65 | °C/W | | |
| Maximum Junction-to-Case (Drain) | R _{thJC} | = | 2.1 | C/VV | | |

| PARAMETER | SYMBOL | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT |
|---|-----------------------|---|--|------|------|-----------|---------|
| Static | | | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} : | = 0 V, I _D = 250 μA | 650 | - | - | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | Referenc | e to 25 °C, I _D = 1 mA ^d | - | 670 | - | mV/°C |
| Gate-Source Threshold Voltage | V _{GS(th)} | V _{DS} = | = V _{GS} , I _D = 250 μA | 2.0 | - | 4.0 | V |
| Gate-Source Leakage | I _{GSS} | , | V _{GS} = ± 30 V | ı | - | ± 100 | nA |
| Zero Gate Voltage Drain Current | I _{DSS} | | = 650 V, V _{GS} = 0 V V, V _{GS} = 0 V, T _J = 125 °C | - | - | 25 250 | μA |
| Drain-Source On-State Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D = 1 A b | - | 4.0 | - | Ω |
| Forward Transconductance | 9 _{fs} | V _{DS} | = 50 V, I _D = 1 A | 3.9 | - | - | S |
| Dynamic | | 1 | | | | | 1 |
| Input Capacitance | C _{iss} | | $V_{GS} = 0 V$, | - | 417 | - | |
| Output Capacitance | C _{oss} | | $V_{DS} = 25 \text{ V},$ | - | 45 | - | 1 |
| Reverse Transfer Capacitance | C _{rss} | f = 1 | .0 MHz, see fig. 5 | - | 5 | - | |
| Output Capacitance | C _{oss} | | V _{DS} = 1.0 V, f = 1.0 MHz | ı | 912 | - | pF |
| Output Capacitance | | V _{GS} = 0 V | V _{DS} = 520 V, f = 1.0 MHz | ı | 26 | | |
| Effective Output Capacitance | Coss eff. | | V _{DS} = 0 V to 520 V ^c | | 42 | - | |
| Total Gate Charge | Q_g | | | - | - | 11 | |
| Gate-Source Charge | Q_{gs} | V _{GS} = 10 V | $V_{GS} = 10 \text{ V}$ $I_D = 1.2 \text{ A}, V_{DS} = 400 \text{ V}$ see fig. 6 and 13 ^b | | - | 2.3 | nC |
| Gate-Drain Charge | Q_{gd} | | | | - | 5.2 | |
| Turn-On Delay Time | t _{d(on)} | | 1 | | 14 | - | |
| Rise Time | t _r | | = 325 V, I _D = 1.2A | i | 20 | - | |
| Turn-Off Delay Time | t _{d(off)} | $R_{G} =$ | $R_G = 9.1 \Omega, R_D = 62 \Omega,$ see fig. 10^b | | 34 | - | ns - |
| Fall Time | t _f | j | | - | 18 | - | |
| Drain-Source Body Diode Characteristic | s | | | | | | |
| Continuous Source-Drain Diode Current | I _S | MOSFET symbol showing the integral reverse p - n junction diode | | - | - | 2 | A |
| Pulsed Diode Forward Current ^a | I _{SM} | | | - | - | 8 | |
| Body Diode Voltage | V_{SD} | T _J = 25 °C, I _S = 3.2 A, V _{GS} = 0 V ^b | | - | - | 1.5 | V |
| Body Diode Reverse Recovery Time | t _{rr} | T. = 25 °C L | T 25 00 1 2 2 A 21/24 400 A / 22h | | 180 | 230 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | $T_J = 25 ^{\circ}\text{C}, I_F = 3.2 \text{A}, dI/dt = 100 \text{A/}\mu\text{s}^{\text{b}}$ | | - | 2.1 | 3.2 | μC |
| Forward Turn-On Time | t _{on} | Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D) | | | | | |

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s$; duty cycle $\leq 2~\%$. c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .
- d. t = 60 s, f = 60 Hz.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

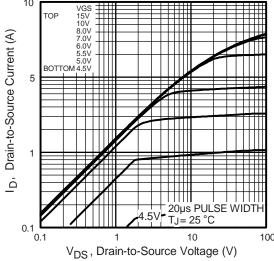


Fig. 1 - Typical Output Characteristics

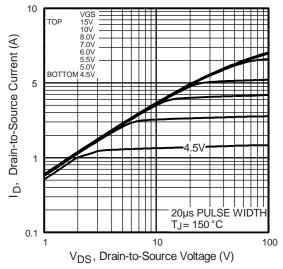


Fig. 2 - Typical Output Characteristics

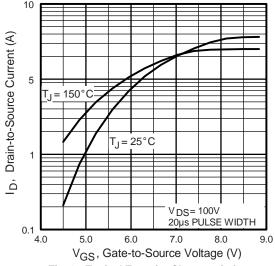


Fig. 3 - Typical Transfer Characteristics

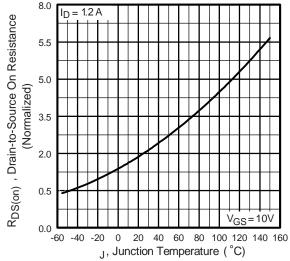


Fig. 4 - Normalized On-Resistance vs. Temperature



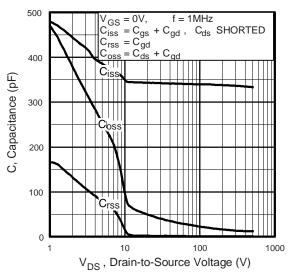


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

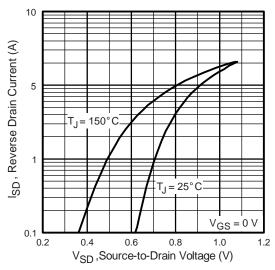


Fig. 7 - Typical Source-Drain Diode Forward Voltage

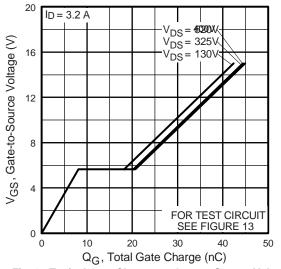


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

4

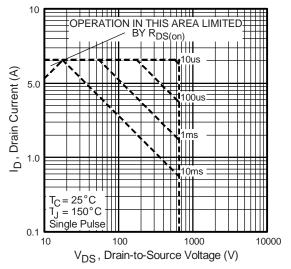


Fig. 8 - Maximum Safe Operating Area



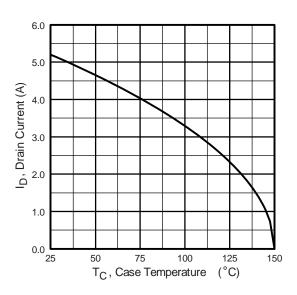


Fig. 9 - Maximum Drain Current vs. Case Temperature

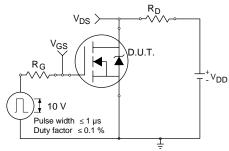


Fig. 10a - Switching Time Test Circuit

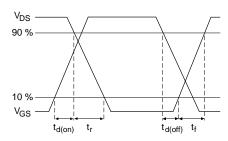


Fig. 10b - Switching Time Waveforms

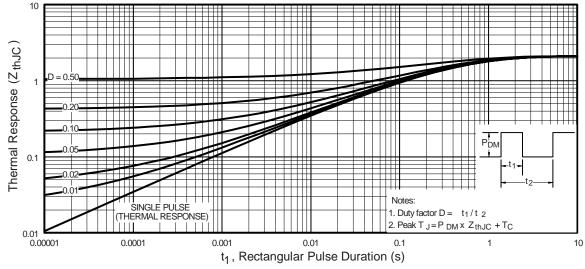


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

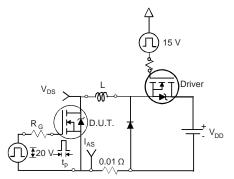


Fig. 12a - Unclamped Inductive Test Circuit

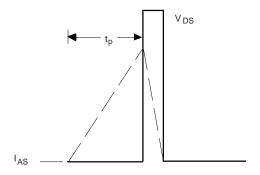


Fig. 12b - Unclamped Inductive Waveforms



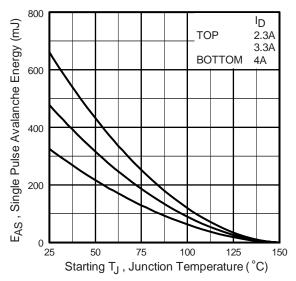


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

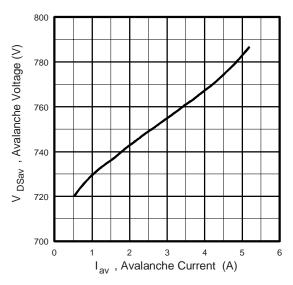


Fig. 12d - Typical Drain-to Source Voltage vs. Avalanche Current

6

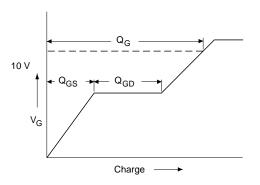


Fig. 13a - Basic Gate Charge Waveform

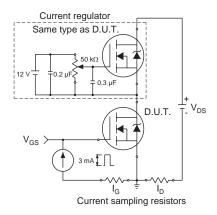
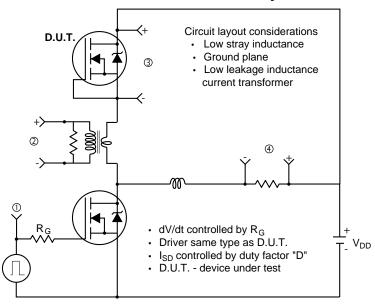


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



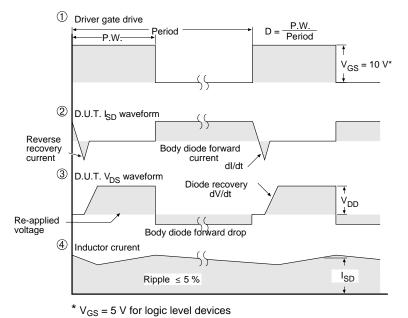
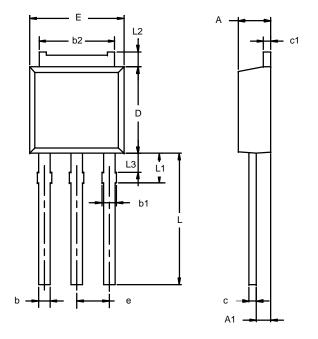


Fig. 14 - For N-Channel



TO-251AA



| Note: D | Dimension | L3 is for | reference | only. |
|---------|-----------|-----------|-----------|-------|
|---------|-----------|-----------|-----------|-------|

| | MILLIM | IETERS | INC | IES | |
|-----|----------|--------|-------|-------|--|
| Dim | Min | Max | Min | Max | |
| Α | 2.21 | 2.38 | 0.087 | 0.094 | |
| A1 | 0.89 | 1.14 | 0.035 | 0.045 | |
| b | 0.71 | 0.89 | 0.028 | 0.035 | |
| b1 | 0.76 | 1.14 | 0.030 | 0.045 | |
| b2 | 5.23 | 5.43 | 0.206 | 0.214 | |
| С | 0.46 | 0.58 | 0.018 | 0.023 | |
| с1 | 0.46 | 0.58 | 0.018 | 0.023 | |
| D | 5.97 | 6.22 | 0.235 | 0.245 | |
| Е | 6.48 | 6.73 | 0.255 | 0.265 | |
| е | 2.28 BSC | | 0.090 | BSC | |
| L | 3.89 | 9.53 | 0.153 | 0.375 | |
| L1 | 1.91 | 2.28 | 0.075 | 0.090 | |
| L2 | 0.89 | 1.27 | 0.035 | 0.050 | |
| L3 | 1.15 | 1.52 | 0.045 | 0.060 | |



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